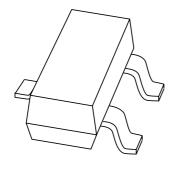
### **DISCRETE SEMICONDUCTORS**

# DATA SHEET



### BAS29; BAS31; BAS35 General purpose controlled avalanche (double) diodes

Product data sheet Supersedes data of 2001 Oct 10 2003 Mar 20



## General purpose controlled avalanche (double) diodes

BAS29; BAS31; BAS35

#### **FEATURES**

• Small plastic SMD package

• Switching speed: max. 50 ns

· General application

• Continuous reverse voltage: max. 90 V

• Repetitive peak reverse voltage: max. 110 V

· Repetitive peak forward current: max. 600 mA

• Repetitive peak reverse current: max. 600 mA.

#### **APPLICATIONS**

General purpose switching in e.g. surface mounted circuits.

#### **DESCRIPTION**

General purpose switching diodes fabricated in planar technology, and encapsulated in small rectangular plastic SMD SOT23 packages. The BAS29 consists of a single diode. The BAS31 has two diodes in series. The BAS35 has two diodes with a common anode.

#### **MARKING**

TYPE NUMBER	MARKING CODE(1)
BAS29	L20 or *A8
BAS31	L21 or *V1
BAS35	L22 or *V2

#### Note

\* = p : Made in Hong Kong.
\* = t : Made in Malaysia.
\* = W : Made in China.

#### **PINNING**

PIN			
FIN			BAS35
1	anode	anode	cathode (k1)
2	not connected	cathode	cathode (k2)
3	cathode	common connection	common anode

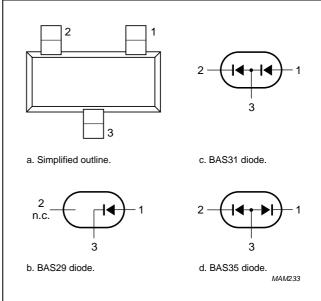


Fig.1 Simplified outline (SOT23) and symbols.

# General purpose controlled avalanche (double) diodes

BAS29; BAS31; BAS35

#### **LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
Per diode					
$V_{RRM}$	repetitive peak reverse voltage		_	110	V
$V_R$	continuous reverse voltage		_	90	V
I <sub>F</sub>	continuous forward current	single diode loaded; see Fig.2; note 1	_	250	mA
		double diode loaded; see Fig.2; note 1	_	150	mA
I <sub>FRM</sub>	repetitive peak forward current		_	600	mA
I <sub>FSM</sub>	non-repetitive peak forward current	square wave; T <sub>j</sub> = 25 °C prior to surge; see Fig.4			
		t = 1 μs	_	10	Α
		t = 100 μs	_	4	Α
		t = 1 s	_	0.75	Α
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> = 25 °C; note 1	_	250	mW
I <sub>RRM</sub>	repetitive peak reverse current		_	600	mA
E <sub>RRM</sub>	repetitive peak reverse energy	$t_p \ge 50 \ \mu s; \ f \le 20 \ Hz; \ T_j = 25 \ ^{\circ}C$	_	5	mJ
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature		_	150	°C

#### Note

<sup>1.</sup> Device mounted on an FR4 printed-circuit board.

# General purpose controlled avalanche (double) diodes

BAS29; BAS31; BAS35

#### **ELECTRICAL CHARACTERISTICS**

 $T_j = 25$  °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
Per diode					
V <sub>F</sub>	forward voltage	see Fig.3			
		I <sub>F</sub> = 10 mA	_	750	mV
		I <sub>F</sub> = 50 mA	_	840	mV
		I <sub>F</sub> = 100 mA	_	900	mV
		I <sub>F</sub> = 200 mA	_	1	V
		$I_F = 400 \text{ mA}$	_	1.25	V
I <sub>R</sub>	reverse current	see Fig.5			
		V <sub>R</sub> = 90 V	_	100	nA
		V <sub>R</sub> = 90 V; T <sub>j</sub> = 150 °C	_	100	μΑ
V <sub>(BR)R</sub>	reverse avalanche breakdown voltage	I <sub>R</sub> = 1 mA	120	170	V
C <sub>d</sub>	diode capacitance	f = 1 MHz; V <sub>R</sub> = 0; see Fig.6	_	35	pF
t <sub>rr</sub>	reverse recovery time	when switched from $I_F$ = 30 mA to $I_R$ = 30 mA; $R_L$ = 100 $\Omega$ ; measured at $I_R$ = 3 mA; see Fig.7	_	50	ns

#### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th j-tp</sub>	thermal resistance from junction to tie-point		360	K/W
R <sub>th j-a</sub>	thermal resistance from junction to ambient	note 1	500	K/W

#### Note

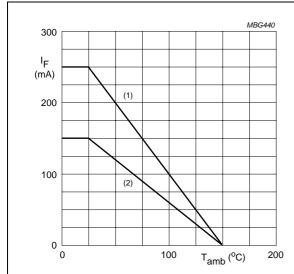
1. Device mounted on an FR4 printed-circuit board.

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## General purpose controlled avalanche (double) diodes

BAS29; BAS31; BAS35

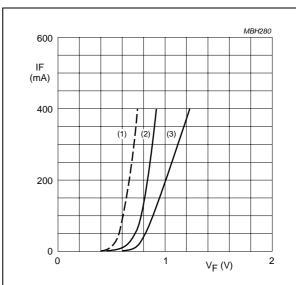
#### **GRAPHICAL DATA**



Device mounted on an FR4 printed-circuit board.

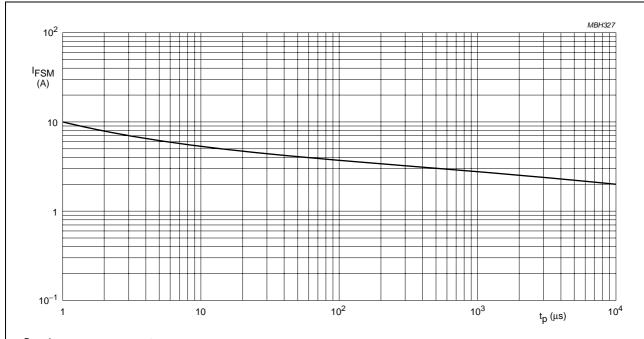
- (1) Single diode loaded.
- (2) Double diode loaded.

Fig.2 Maximum permissible continuous forward current as a function of ambient temperature.



- (1)  $T_j = 150$  °C; typical values.
- (2)  $T_j = 25$  °C; typical values.
- (3)  $T_j = 25$  °C; maximum values.

Fig.3 Forward current as a function of forward voltage.



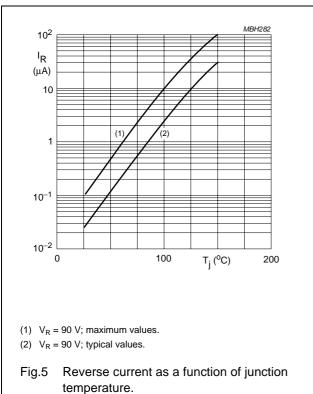
Based on square wave currents.

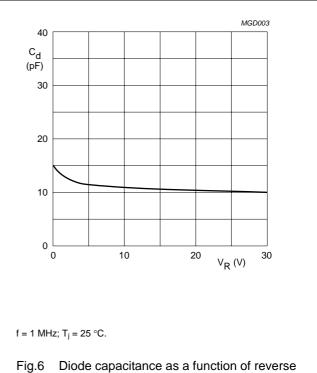
 $T_j$  = 25 °C prior to surge.

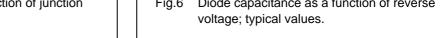
Fig.4 Maximum permissible non-repetitive peak forward current as a function of pulse duration.

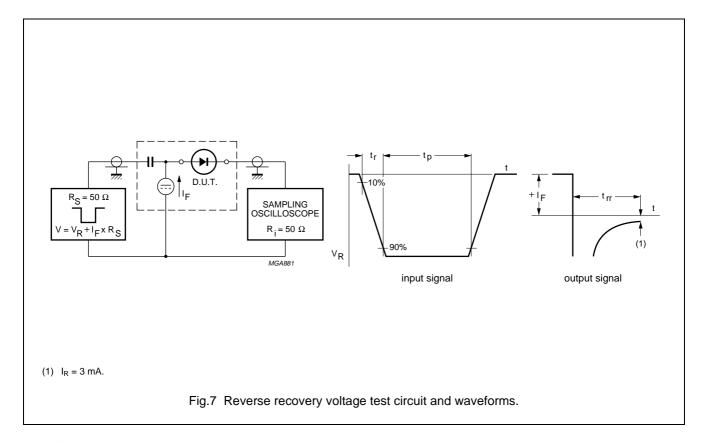
# General purpose controlled avalanche (double) diodes

BAS29; BAS31; BAS35









# General purpose controlled avalanche (double) diodes

BAS29; BAS31; BAS35

#### **PACKAGE OUTLINE**

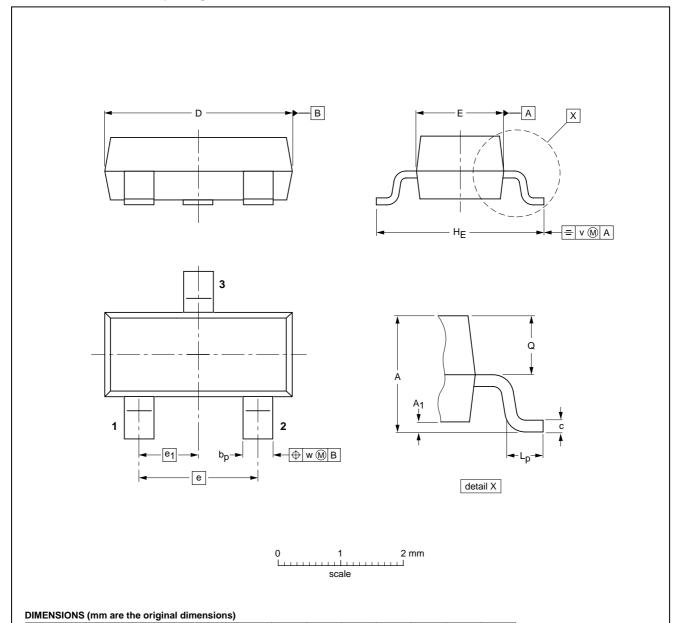
UNIT

mm

Α

Plastic surface mounted package; 3 leads

SOT23



OUTLINE	REFERENCES		EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT23		TO-236AB				<del>97-02-28</del> 99-09-13

Q

0.55

0.45

w

0.1

2003 Mar 20 7

 $b_p$ 

0.48

0.38

0.1

D

3.0

2.8

С

0.15

0.09

Ε

1.4

е

1.9

e<sub>1</sub>

0.95

 $H_{\mathsf{E}}$ 

 $L_{p}$ 

0.45

0.15

### General purpose controlled avalanche (double) diodes

BAS29; BAS31; BAS35

#### **DATA SHEET STATUS**

DOCUMENT STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)</sup>	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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